

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/501,302	NEUPART, LARS	
Examiner	Art Unit	
Shin-Hon Chen	2131	

	SEARCHED		
Class	Subclass	Date	Examiner
		5,0	•
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
USPAT, PGPUB, DERWENT, JPO, EPO (BRS search)	10/25/2006	S.C.
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